

Search Notes

Application/Control No.

10/066,405

Examiner

James H. Blackwell

Applicant(s)/Patent under
Reexamination

AOYAMA ET AL.

Art Unit

2176

SEARCHED

Class	Subclass	Date	Examiner
715	511 (US Only)	10/24/2005	JB
707	100(US)	10/24/2005	JB
703	27(US)	10/24/2005	JB
707	9(US)	10/24/2005	JB
709	246(US)	10/24/2005	JB
709	223(US)	10/24/2005	JB
705	37(US)	10/24/2005	JB
719	330(US)	10/24/2005	JB
715	530(US)	10/24/2005	JB

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
715	511	10/24/2005	JB
709	246	10/24/2005	JB

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East (Updated, text only search, see enclosed search history)	10/24/2005	JB
Interference search performed	10/27/2005	JB
keyword search of ACM database	10/27/2005	JB
keyword search of IEEE database	10/27/2005	JB